

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/714,532	KAIKURANTA, TERHO	
Examiner		Art Unit		Page 1 of 1
Jeff Piziali		2629		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,995,752 B2	02-2006	Lu, Jin	345/174
*	B	US-6,943,779 B2	09-2005	Satoh, Mitsuru	345/173
*	C	US-6,750,852 B2	06-2004	Gillespie et al.	345/173
*	D	US-6,292,173 B1	09-2001	Rambaldi et al.	345/157
*	E	US-6,255,604 B1	07-2001	Tokioka et al.	178/18.01
*	F	US-6,246,395 B1	06-2001	Goyins et al.	345/173
*	G	US-6,037,882 A	03-2000	Levy, David H.	341/20
*	H	US-5,943,043 A	08-1999	Furuhasha et al.	345/173
*	I	US-5,825,352 A	10-1998	Bisset et al.	345/173
*	J	US-5,764,222 A	06-1998	Shieh, Johnny Meng-Han	345/173
*	K	US-5,589,856 A	12-1996	Stein et al.	345/173
*	L	US-5,402,151 A	03-1995	Duwaer, Arne L.	345/173
*	M	US-4,914,624 A	04-1990	Dunthorn, David I.	345/173

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.